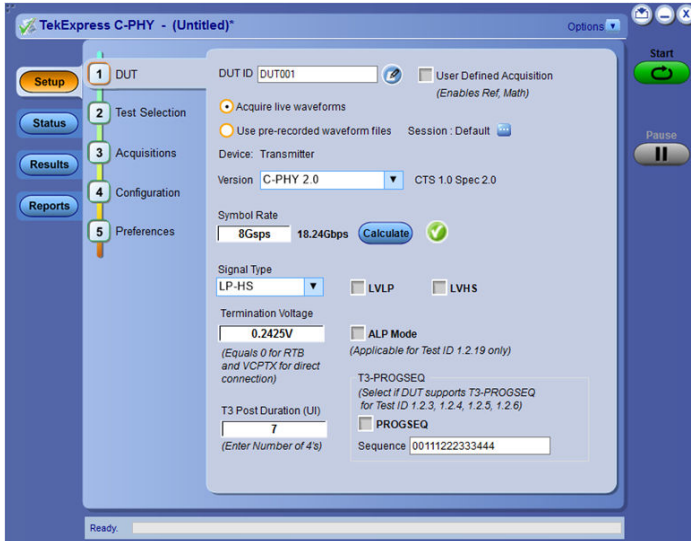


## C-PHY Transmitter Solution

### TekExpress MIPI C-PHY Transmitter Test Application CPHY20 / 6-CMCPHY20 Datasheet



The Tektronix TekExpress® C-PHY20 application offers a complete physical layer test solution for transmitter conformance and characterization as defined in the MIPI C-PHY v2.0, v1.1 and v1.0 specification. TekExpress C-PHY solution provides easy way to measure and characterize C-PHY data links. TekExpress C-PHY v2.0 automated test solution along with 70K DX/SX or a MSO6/6B oscilloscopes provides an easy way to test, debug and characterize the electrical and timing measurements of C-PHY.

#### Key features

##### Transmitter testing:

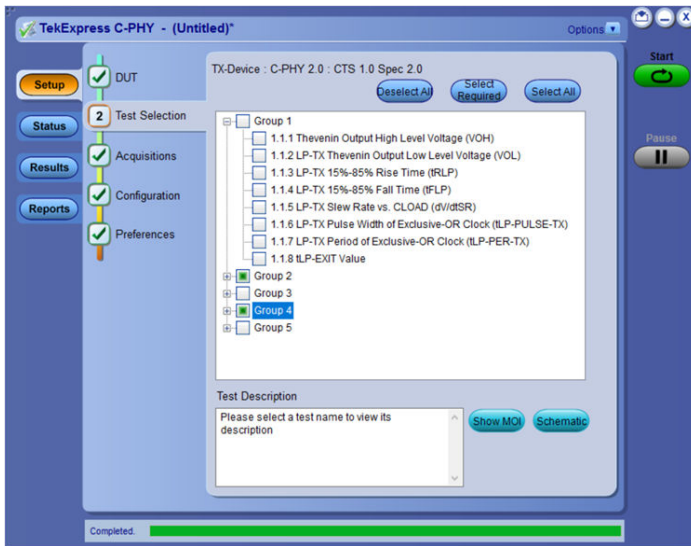
- **Dynamic Symbol Rate:** Supports Dynamic Symbol Rate updating for the waveform captured.
- Measures the rise time and fall time of the DUT C-PHY signals.
- Verifies that the static point common mode voltage VCPTX of the trio signal is within the transmitter limit.
- C-PHY Tx 2.0 delivers 100% Automated TekExpress based C-PHY solution for all the Tx measurement.
- Supports CPHY specification version for MIPI CPHY 1.0, 1.1, and 2.0
- Live and pre-acquired waveform Analysis
- Easily select and configure the desired tests
- Modify limits of test parameters for debug, margin, and characterization testing
- Supports LP-TX and HS-TX signaling tests at highest symbol rate – 8GS/s

- Options to select LVLP and LVHS and ALP mode functionality for LP and HS tests.
- Supports Eye Diagram Test with CTLE for symbol rates above 3.5 GS/s and without CTLE at symbol rates below 3.5 GS/s
- Supports Hexagonal shaped eye diagram for devices with maximum operating symbol rates <1 GS/s and for devices with maximum operating symbol rates ≥1 GS/s, a diamond shaped eye diagram is displayed.
- Supports horizontal mask movement to a position where there are zero mask hits.
- User defined options to select three reference templates (Short, Standard, and Long) for differential insertion loss that are applicable for all symbol rates.
- Provision to test LP-TX timing and behavioral tests such as initialization (INIT), Ultra-Low Power State (ULPS), and Bus Turnaround (BTA)
- Supports HS burst signaling tests in the HS Unterminated Mode
- Support HS-TX Calibration Preamble measurements
- Provision to run in user defined mode with user defined parameters for triggering the LP-HS signals
- Manual Cursor Mode support to enable the user to capture and measure the desired LP-HS regions.
- Debug Mode support to load waveforms on Ref and Math channels for Analysis
- Reporting measurement test run details and repeatability with option to save the waveforms only for fail test run
- Verifies that the common-mode voltage mismatch ( $\Delta V_{CMTPX}$ ) of the DUT Data Lane HS transmitter is less than the maximum conformance limit.
- Verifies that the common-mode level variation is between 50 MHz to 450 MHz.
- Verifies that the common-mode level variation is above 450 MHz.
- Modifies limits in TekExpress for debug and characterization.

#### Applications

- Automotive camera and display
- Mobile camera and display
- Camera CMOS Image sensors
- Display Driver ICs
- Application processor for mobile devices
- Wearable technologies
- Internet of Things (IoT)
- Drones
- Personal Computers

## MIPI C-PHY transmitter test

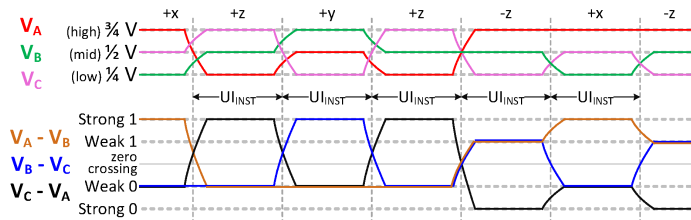


MIPI® C-PHY v2.0 provides throughput high performance over bandwidth limited channels for connecting to peripherals, including displays and cameras. This interface allows the system designers to easily scale the existing MIPI® Alliance Camera Serial Interface (CSI-2) ecosystem to support higher resolution image sensors with less power consumption.

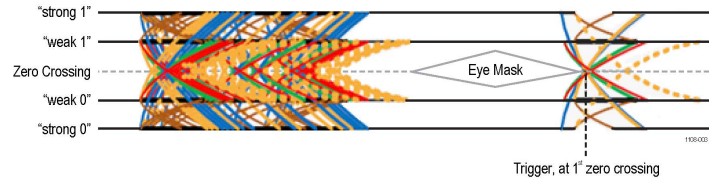
MIPI® C-PHY and MIPI® D-PHY are pin compatible, allowing connections to the companion device with either technology. C-PHY was designed to coexist on the same IC pin as D-PHY so that dual-mode devices can be developed.

MIPI C-PHY introduces 3-phase symbol encoding offering 2.28 bits per symbol to transmit data symbols on 3-wire lanes or trios, where each trio includes an embedded clock.

C-PHY signals have three levels and they are single-ended. They are represented as LineA, LineB, and LineC. At any given point in time, no signals are at the same voltage levels. The receiver side is differential and displays four different voltage levels; Strong 1, Weak 1, Strong 0, and Weak 0. The receiver however views either logic 1 or logic 0.



Voltage levels



Eye mask

## C-PHY clock recovery

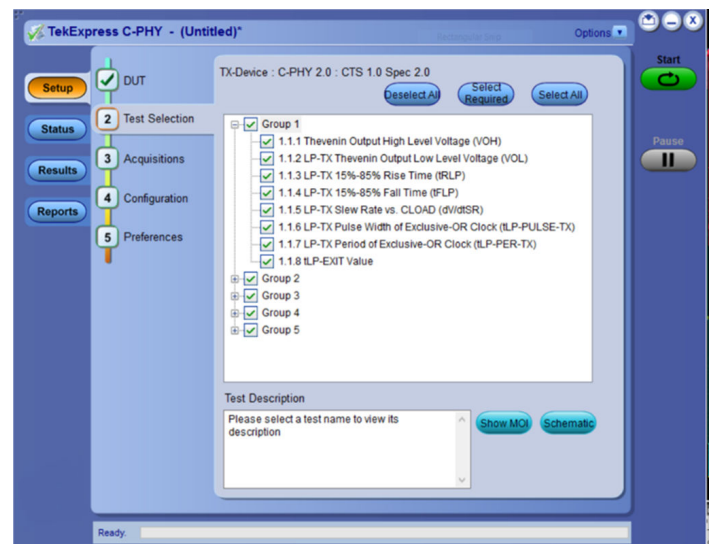
C-PHY uses a unique mechanism for clock recovery. C-PHY 2.0 implements a custom clock recovery algorithm referred to as *Triggered Eye*. In this model, the first zero crossing of the three differential signals is used as a trigger point for clock recovery and to render the eye diagram.

The mask is aligned to right most passing position for triggered eye.

## C-PHY transmitter test measurements

For meeting the conformance requirements of C-PHY v2.0 CTS v1.0, following tests/measurements are executed.

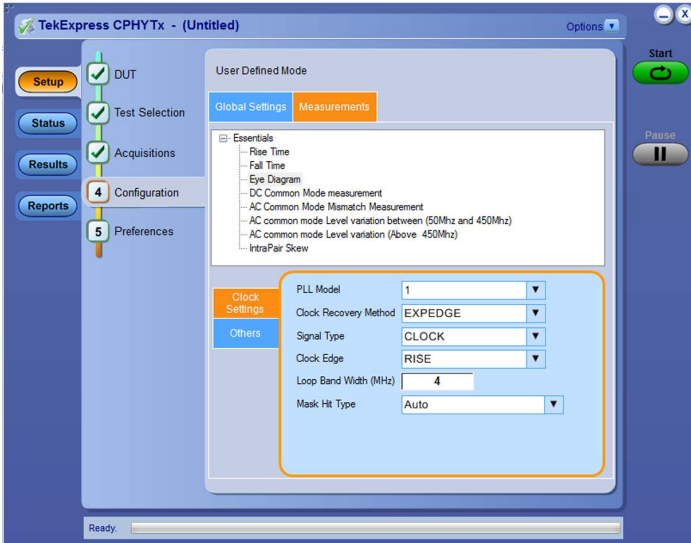
- LP tests
- HS Timing tests
- HS Electrical tests
- LP Timing Tests manual
- BIDIR Timing Tests
- DC Level Test
- CAL PRE Timing Tests



C-PHY v2.0 Transmitter measurements

## Custom-triggered eye diagram

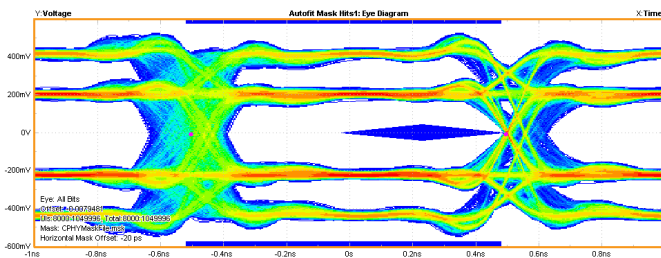
The following figure displays the TekExpress C-PHY TX Test software being configured for a custom-triggered eye diagram, with auto mask position for optimal mask placement.



C-PHY TX Essentials

## Eye diagram analysis

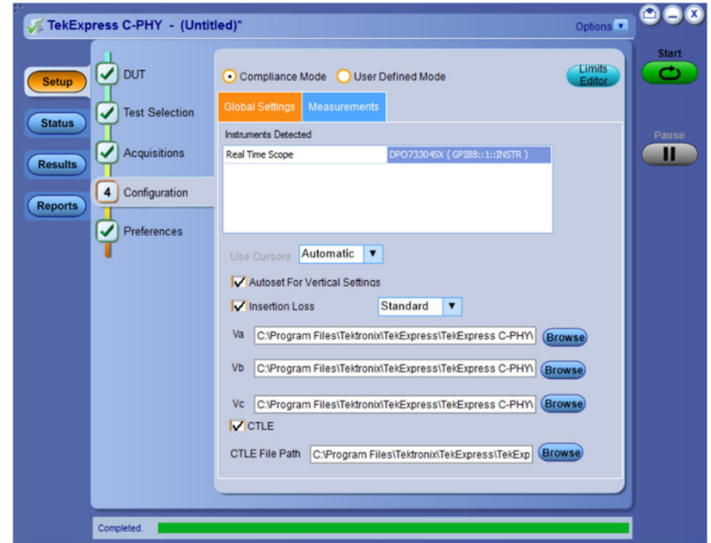
The Jitter and Eye diagram rendering performed over the entire record length helps designers to characterize the devices better by displaying anomalies of the device over an extended period. The software allows you to run the eye diagram analysis for 3M UI (1M on each differential pair) and overnight run for a detailed characterization.



Eye diagram analysis

## Insertion loss

As part of characterizing the device, designers need to embed or de-embed insertion loss. This is supported using the filter files as shown in the following figure.

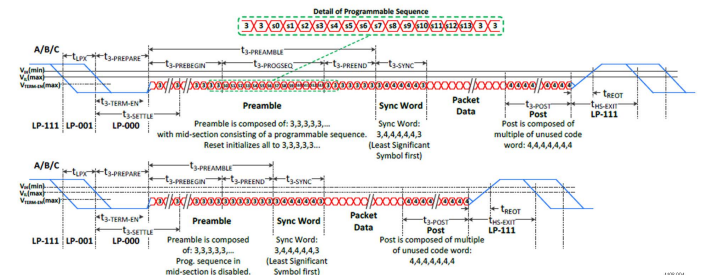


Insertion loss

## Signaling and termination

C-PHY signaling is similar to D-PHY. For instance, it dynamically switches from LP mode to HS Mode in the timing measurements defined for C-PHY.

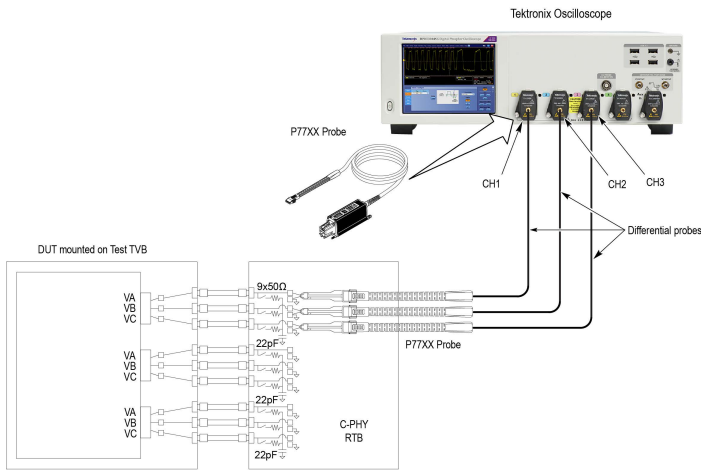
The following figure is from the MIPI Alliance C-PHY specification v2.0. It shows the structure of a C-PHY signal (HS data transmission in Burst).



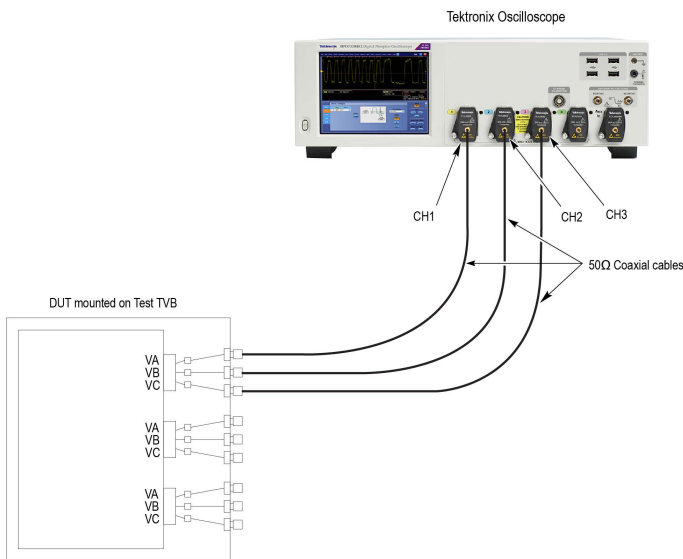
C-PHY signal (HS data transmission in Burst)

To take measurements during this switchable termination mode, load boards or termination boards are needed. The physical setup for taking these measurements require an oscilloscope, probes, and a termination board.

The following figure shows the physical set up for HS measurements. Termination board and probes are not required for HS measurements, you can connect SMA cables directly.



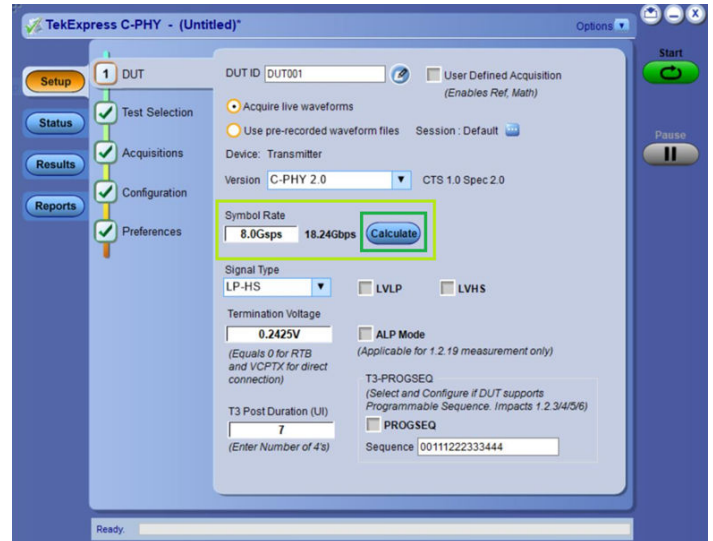
LP-HS with RTB



HS without RTB

## Dynamic Symbol Rate

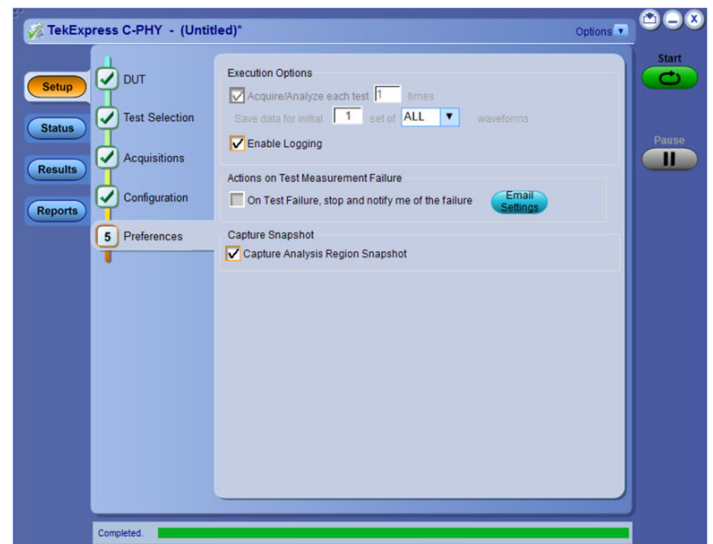
Quite often the end user is not aware of the exact symbol rate in the system/device under test. Dynamic Symbol Rate feature addresses this by enabling user to measure/calculate and validate signal's symbol rate before running measurement, if he/she is not aware of the symbol rate. This helps in enabling user to save time by avoiding unnecessary iterations because of invalid symbol rate.



Calculate Symbol Rate

## Multi-Run

Multi-Run is an option to the user to perform the measurements for a user defined number of iterations. The report would list the results for all the iterations, and the statistics table would additionally compute and report the statistics across the measured values.



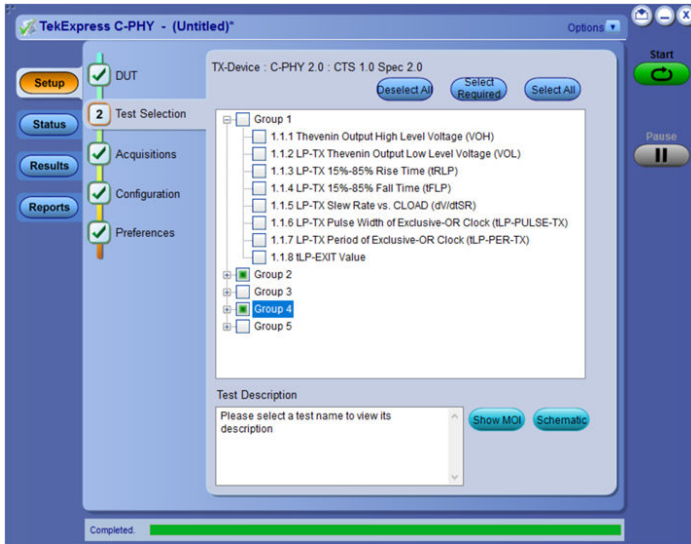
## TekExpress Automated Solution

The Tektronix TekExpress C-PHY application runs on DPO/MSO 70000 DX/SX with Option-DJA , Series 6 Series B MSO with Options, 6-DJA and Option 6-WIN installed (Windows 10 operating system). The close integration of the oscilloscope and test software provides an automated, simple, and efficient way to test C-PHY transmitter interfaces and devices consistent to the requirements of the C-PHY v2.0, Conformance Test Specification revision 1.0.



Measurement setup and test execution is simple with the C-PHY Transmitter software. The intuitive Graphical User Interface (GUI) is laid out to represent the workflow from setup through testing, letting you focus on design and debug instead of setting up the measurements.

Simply select tests from the menu for HS, LP, and HS-LP groups as per specifications.



Select test groups or individual tests from the Test Selection menu

You can view the schematic of the selected test with a push of a button. You can also display a test connection diagram to avoid setup errors.

## Test report

C-PHY2.0 automated compliance test application creates compliance test documentation quickly with a summary report in .mht or .pdf or .csv format. The software automatically generates a report after test execution is complete, and includes Pass/Fail status, test margin and images to help you quickly analyze the test results. The report also includes test configuration details, waveform plots, oscilloscope screen shots, and margin analysis to provide more insights into your design.

Tektronix®

TekExpress C-PHY

Transmitter Test Report

Setup Information

DUT ID	DUT001	Scope Model	DPO73304DX
Date/Time	7/23/2021 3:49:27 AM	Scope Serial Number	8260572
Symbol Rate(Gbps)	1	Scope F/W Version	10.11.11 Build 19
Signal Type	LP-HS	DPOJET Version	10.2.0.8
Compliance Mode	Yes	VA: (Source, Probe Model-Serial)	CH1, P75TFLXA-P7720-A078761.8013224
Acquisition Mode	Live	VB: (Deskew(ps))	0
Device Type	TX-Device	VC: (Source, Probe Model-Serial)	CH2, P75TFLXA-P7720-A078681.8013120
TekExpress C-PHY Version	10.0.1.203	VD: (Deskew(ps))	0
TekExpress Framework Version	5.6.0.102	VE: (Source, Probe Model-Serial)	CH3, P75TFLXA-P7720-A043643.P100017
C-PHY version	C-PHY 2.0	VF: (Deskew(ps))	0
Measurement Method	Automatic		
User Defined Acquisition	No		
Overall Test Result	Pass		
Overall Execution Time	00:00:39		
DUT COMMENT:	General Comment - C-PHY		

Test Name Summary Table

1.4.3 HS-TX Single-Ended Output High Voltages Undertimed (VOHHS(UT)/VA/VOHHS(UT)/VB/VOHHS(UT)/VC)			
Pass			
1.4.4 HS-TX Static Common-Point Voltages Undertimed (VCPTX(UT))			
Pass			

1.4.3 HS-TX Single-Ended Output High Voltages Undertimed (VOHHS(UT)/VA/VOHHS(UT)/VB/VOHHS(UT)/VC)

Lane	Measurement Details	Iteration	Measured Value	Units	Test Result	Margin	Low Limit	High Limit
Lane 0	HS-TX VOHHS Undertimed (VOHHS(UT)/VA)	1	357.412	mV	Pass	LL: NA, HL: 67.588	NA	425
Lane 0	HS-TX VOHHS Undertimed (VOHHS(UT)/VB)	1	345.242	mV	Pass	LL: NA, HL: 79.758	NA	425
Lane 0	HS-TX VOHHS Undertimed (VOHHS(UT)/VC)	1	348.469	mV	Pass	LL: NA, HL: 76.531	NA	425

COMMENTS

1.4.4 HS-TX Static Common-Point Voltages Undertimed (VCPTX(UT))

Lane	Measurement Details	Iteration	Measured Value	Units	Test Result	Margin	Low Limit	High Limit
Lane 0	HS-TX VCPTX Undertimed (VCPTX_HS_X)	1	223.286	mV	Pass	LL: 73.286, HL: 21.714	150	245
Lane 0	HS-TX VCPTX Undertimed (VCPTX_HS_X)	1	224.511	mV	Pass	LL: 74.511, HL: 20.489	150	245
Lane 0	HS-TX VCPTX Undertimed (VCPTX_HS_Y)	1	222.588	mV	Pass	LL: 72.588, HL: 22.412	150	245
Lane 0	HS-TX VCPTX Undertimed (VCPTX_HS_Y)	1	226.1	mV	Pass	LL: 76.1, HL: 18.9	150	245
Lane 0	HS-TX VCPTX Undertimed (VCPTX_HS_Z)	1	228.644	mV	Pass	LL: 78.644, HL: 16.356	150	245
Lane 0	HS-TX VCPTX Undertimed (VCPTX_HS_Z)	1	218.728	mV	Pass	LL: 68.728, HL: 26.272	150	245

COMMENTS

Back to Summary Table

Back to Summary Table

Detailed report with summary table

## P7700/TDP7700 probe for MIPI CPHY20 / 6-CMCPHY20

The MIPI application requires a special type of probing because of different impedances in High Speed and Low Power modes. In High Speed mode, C-PHY signals are in terminated environment. In Low Power mode, C-PHY signals are operated in unterminated environment with single-ended signals. MIPI C-PHY has two main requirements for probing:

- Provide high impedance
- Differential and single-ended mode

The P7700 Series probe provides an active buffer tip, few millimeters away from the end of tip. This provides the best signal fidelity for MIPI C-PHY application along with flexible connectivity options.

The TriMode probe helps to create differential, single-ended, and common mode measurements accurately with the probe setup. This unique capability allows you to work more effectively and efficiently, switching between differential, single-ended and common mode measurements without moving the probe's connection points.



*P7700 Series TriMode probe*

You can be confident in the signal fidelity of your measurements. The innovative new probe design uses SiGe Technology to provide the bandwidth and fidelity needed today and in the future.

The P7700 Series TriMode probe architecture provides:

- An active buffer amplifier on the tips with the probe input only 3.2 mm from the input
- Excellent step response and low insertion loss up to 20 GHz
- Low-DUT loading with 100 k $\Omega$  (DC) and 0.4 pF (AC) performance
- High CMRR
- Low noise

## Specifications

All specifications apply to all models unless noted otherwise.

### Test parameters

Parameter group	Parameter name	Range	Default	Units
Ref levels	Reference levels	Absolute, Percentage	Percentage	NA
	Reference level-High (%)	70 to 90 (in %) 40 to 60 (in Absolute)	80 (in %) 58 (in Absolute)	% or V
	Reference level-Low (%)	10 to 30 (in %) -60 to -40 (in Absolute)	20 (in %) -58 (in Absolute)	
	Reference level-Hysteresis (%)	5 to 15 (in %) 5 to 25 (in Absolute)	10 (in %) 10 (in Absolute)	
Clock Settings	Clock recovery method	EXPEDGE EXPPLL	EXPEDGE	NA
	Signal Type	CLOCK DATA AUTO	CLOCK	
	Clock Edge	RISE FALL BOTH	RISE	
	Loop bandwidth (MHz)	1 to 10	4	MHz
	MaskHitType	Auto Manual	Auto	NA
Others	Accumulation	True False	True	NA
	Eye Height Percentage	10 to 90	50	%
	Hysteresis	5 to 15	10	%

## Minimum system requirements

Operating system	Windows 10, 64-bit
Firmware	DPO/MSO TekScope v10.11.0 or later and DPOJET version is 10.2.0 and above
Software requirements	Microsoft .NET 4.0 Framework Microsoft Internet Explorer 6.0 SP1 or later Adobe Reader 7.0 or equivalent software for viewing portable document format (PDF) files



**Note:** If TekExpress is installed on a Tektronix oscilloscope, TekExpress uses a virtual GPIB port to communicate with oscilloscope applications. If external GPIB communication devices such as USB-GPIB HS or equivalent are used for instrument connectivity make sure that the Talker Listener utility is enabled in the DPO/DSA/MSO oscilloscope GPIB menu. For ease of use, connect to an external (secondary) monitor.

## Transmitter test specification

C-PHY specification Revision 2.0

C-PHY Conformance Test specification Revision 1.0

Test Type	CTS Test ID	Test Name Connection type
LP Tests	1.1.1	LP-TX Thevenin Output High Level Voltage (VOH)
	1.1.2	LP-TX Thevenin Output Low Level Voltage (VOL) ESCAPEMODE
		LP-TX Thevenin Output Low Level Voltage (VOL)
	1.1.3	LP-TX 15%-85% Rise Time (TRLP) ESCAPEMODE
	1.1.4	LP-TX 15%-85% Fall Time (TFLP) ESCAPEMODE
		LP-TX 15%-85% Fall Time (TFLP)
	1.1.5	LP-TX Slew Rate vs. CLOAD (RiseEdgeMax)
		LP-TX Slew Rate vs. CLOAD (RiseEdgeMin)
		LP-TX Slew Rate vs. CLOAD (RiseEdgeMargin)
		LP-TX Slew Rate vs. CLOAD (FallEdgeMax)
		LP-TX Slew Rate vs. CLOAD (FallEdgeMin)
	1.1.6	LP-TX Pulse Width of Exclusive-OR Clock (TLP-PULSE-TX)
		LP-TX Pulse Width of Exclusive-OR Clock (TLP-PULSE-TX) [Initial]
	1.1.7	LP-TX Period of Exclusive-OR Clock (TLP-PER-TX) [Rising-to-Rising]
		LP-TX Period of Exclusive-OR Clock (TLP-PER-TX) [Falling-to-Falling]
	1.1.8	tLP-EXIT Value
HS Timing Tests	1.2.1	TLPX Duration
	1.2.2	T3-PREPARE Duration
	1.2.3	T3-PREBEGIN Duration
	1.2.4	T3-PROGSEQ Duration
	1.2.5	T3-PREEND Duration
Table continued...		



Test Type	CTS Test ID	Test Name Connection type
	1.2.6	T3-SYNC Duration
HS Electrical Tests	1.2.7	HS-TX Differential Voltages (VOD-AB-Strong1) [Max]
		HS-TX Differential Voltages (VOD-AB-Weak1) [Min]
		HS-TX Differential Voltages (VOD-AB-Weak0) [Max]
		HS-TX Differential Voltages (VOD-AB-Strong0) [Min]
		HS-TX Differential Voltages (VOD-BC-Strong1) [Max]
		HS-TX Differential Voltages (VOD-BC-Weak1) [Min]
		HS-TX Differential Voltages (VOD-BC-Weak0) [Max]
		HS-TX Differential Voltages (VOD-BC-Strong0) [Min]
		HS-TX Differential Voltages (VOD-CA-Strong1) [Max]
		HS-TX Differential Voltages (VOD-CA-Weak1) [Min]
		HS-TX Differential Voltages (VOD-CA-Weak0) [Max]
		HS-TX Differential Voltages (VOD-CA-Strong0) [Min]
	1.2.8	HS-TX Differential Voltage Mismatch ( $\Delta$ VOD)
	1.2.9	HS-TX Single-Ended Output High Voltages (VOHHS(VA))
		HS-TX Single-Ended Output High Voltages (VOHHS(VB))
		HS-TX Single-Ended Output High Voltages (VOHHS(VC))
	1.2.10	HS-TX Static Common-Point Voltages (VCPTX_HS_+X)
		HS-TX Static Common-Point Voltages (VCPTX_HS_-X)
		HS-TX Static Common-Point Voltages (VCPTX_HS_+Y)
		HS-TX Static Common-Point Voltages (VCPTX_HS_-Y)
		HS-TX Static Common-Point Voltages (VCPTX_HS_+Z)
		HS-TX Static Common-Point Voltages (VCPTX_HS_-Z)
	1.2.11	HS-TX Static Common-Point Voltage Mismatch ( $\Delta$ VCPTX(HS))
	1.2.12	HS-TX Dynamic Common-Point Variations Between 50-450 MHz ( $\Delta$ VCPTX(LF))
	1.2.13	HS-TX Dynamic Common-Point Variations Above 450 MHz ( $\Delta$ VCPTX(HF))
	1.2.14	HS-TX Rise Time (tR) [1.5Gbps and below]-Applicable for v1.0 only
		HS-TX Rise Time (tR) [above 1.5Gbps]-Applicable for v1.0 only
	1.2.15	HS-TX Fall Time (tF) [1.5Gbps and below]-Applicable for v1.0 only
		HS-TX Fall Time (tF) [above 1.5Gbps]-Applicable for v1.0 only
HS Timing Tests	1.2.16	T3-POST Duration
	1.2.17	30%-85% Post-EoT Rise Time (TREOT)
	1.2.18	THS-EXIT Value
HS Electrical Tests	1.2.19	HS Clock Instantaneous UI (UIINST_Max)
	1.2.20	HS Clock Delta UI ( $\Delta$ UI) [1Gbps and below]-Applicable for v1.0 and V1.1 only
		HS Clock Delta UI ( $\Delta$ UI) [above 1Gbps]-Applicable for v1.0 and V1.1 only
	1.2.21	HS-TX Eye diagram
	1.2.22	HS-TX UI Jitter (UI_JitterPEAK_TX)

Table continued...

Test Type	CTS Test ID	Test Name Connection type
LP Timing Tests manual	1.3.1	INIT: LP-TX Initialization Period (tINIT,MASTER)
	1.3.2	ULPS Exit: Transmitted tWAKEUP Interval
BIDIR Timing Tests	1.3.3	BTA: TX-Side tTA-GO Interval Value
	1.3.4	BTA: RX-Side tTA-SURE Interval Value
	1.3.5	BTA: RX-Side tTA-GET Interval Value
DC Level Tests	1.4.1	[VOD(UT)]
	1.4.2	[Delta VOD(UT)]
	1.4.3	VOOHS(UT)]
	1.4.4	VCPTX(UT)
CAL PRE Timing Tests	1.5.1	t3-CALPREAMBLE Duration (Informative)
	1.5.2	t3-ASID Duration (Informative)
	1.5.3	t3-CALALTSEQ Duration (Informative)
	1.5.4	Calibration Sequence t3-SYNC Duration (Informative)

**Probing configuration**

LineA, LineB, and LineC constitute a lane where each Line requires one probe(3 Probes).

**Triggering**

Edge trigger on V<sub>A</sub>.

**Reports**

CSV, PDF, and MHT formats with images/plots, eye diagrams and histograms as relevant for the acquired waveforms.

## Ordering information

### CPHY20 (70K DX/SX)

Nomenclature	Description	Number
DPO/MSO70000 <sup>1</sup> DX/SX, Option DJA	20 GHz <sup>1</sup> and above (full conformance at 8 Gsps)	1
SDLA (optional)	Serial Data Link analysis	1
P7700	Trimode active probes (13 GHz and above)	3
UNH-IOL-CTB	MIPI C-PHY Reference Termination board (supports up to 4 lanes)	1

Option	Description
Opt. CPHY20	TekExpress C-PHY Transmitter Solution (Node Locked)
DPOFL-CPHY20	TekExpress C-PHY Transmitter Solution (Floating)
DPO-UP CPHY20	TekExpress C-PHY Essentials Transmitter Solution (Upgrade)

### 6-CMCPHY20(MSO6/6B)

Nomenclature	Description	Number
MSO6B <sup>2</sup> with Option 6-DJA	10 GHz <sup>2</sup> and above (upto 4 Gsps)	1
TDP7700	Trimode active probes (8 GHz and above)	3
UNH-IOL-RTB	MIPI C-PHY Reference Termination board (supports up to 4 lanes)	1

Option	Description
Opt. 6-CMCPHY20	TekExpress C-PHY Transmitter Solution (Node Locked)
SUP6-CMCPHY20-FL	TekExpress C-PHY Transmitter Solution (Floating)
SUP6-CMCPHY20	TekExpress C-PHY Essentials Transmitter Solution (Upgrade)

Data Rate	2.5 GHz	4GHz	6GHz	8GHz	10GHz	16GHz	>20*GHz
1.0 Gsps							
2.5 Gsps							
4.0 Gsps							
6.0 Gsps							
8.0 Gsps							

BW vs Symbol rate supported

<sup>1</sup> Lower Bandwidths support lower symbol rates. Refer to table for the Symbol rate /BW supported.

<sup>2</sup> Also supported on MSO6. Lower Oscilloscope Bandwidths support lower symbol rates. Refer to table for the Symbol rate /BW supported

CE Marking Not Applicable.

Tektronix is registered to ISO 9001 and ISO 14001 by SRI Quality System Registrar.



Product(s) complies with IEEE Standard 488.1-1987, RS-232-C, and with Tektronix Standard Codes and Formats.

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 Belgium 00800 2255 4835\*  
 Central East Europe and the Baltics +41 52 675 3777  
 Finland +41 52 675 3777  
 Hong Kong 400 820 5835  
 Japan 81 (120) 441 046  
 Middle East, Asia, and North Africa +41 52 675 3777  
 People's Republic of China 400 820 5835  
 Republic of Korea +822 6917 5084, 822 6917 5080  
 Spain 00800 2255 4835\*  
 Taiwan 886 (2) 2656 6688

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 France 00800 2255 4835\*  
 India 000 800 650 1835  
 Luxembourg +41 52 675 3777  
 The Netherlands 00800 2255 4835\*  
 Poland +41 52 675 3777  
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 Sweden 00800 2255 4835\*  
 United Kingdom & Ireland 00800 2255 4835\*

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 Canada 1 800 833 9200  
 Denmark +45 80 88 1401  
 Germany 00800 2255 4835\*  
 Italy 00800 2255 4835\*  
 Mexico, Central/South America & Caribbean 52 (55) 56 04 50 90  
 Norway 800 16098  
 Portugal 80 08 12370  
 South Africa +41 52 675 3777  
 Switzerland 00800 2255 4835\*  
 USA 1 800 833 9200

\* European toll-free number. If not accessible, call: +41 52 675 3777

**For Further Information.** Tektronix maintains a comprehensive, constantly expanding collection of application notes, technical briefs and other resources to help engineers working on the cutting edge of technology. Please visit [www.tek.com](http://www.tek.com).

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